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Application/Control No.	Applicant(s)/Patent under Reexamination
10/749,206	CHOI, KEE-HOON
Examiner	Art Unit
Biju Chandran	2835

	SEARCHED		
Class	Subclass	Date	Examiner
361	719	2/23/2006	BIC
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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(INCLUDING 3E)	(INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
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